

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceed the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
 - Class Q Military
 - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)

• Rochester is a critical supplier to DLA and meets all industry and DLA standards.

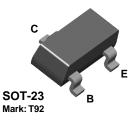
Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.





BSR18A



PNP General Purpose Amplifier

This device is designed as a general purpose amplifier and switching applications at collector currents of 10 μ A to 100 mA. Sourced from Process 66.

Absolute Maximum Ratings* TA = 25°C unless otherwise noted

Symbol	Parameter	Value	Units	
V _{CEO}	Collector-Emitter Voltage	40	V	
V _{CBO}	Collector-Base Voltage	40	V	
V _{EBO}	Emitter-Base Voltage	5.0	V	
I _C	Collector Current - Continuous	200	mA	
T _J , T _{stg}	Operating and Storage Junction Temperature Range	-55 to +150	°C	

*These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

NOTES: 1) These ratings are based on a maximum junction temperature of 150 degrees C.

3) These ratings are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
 3) All voltages (V) and currents (A) are negative polarity for PNP transistors.

Thermal Characteristics TA = 25°C unless otherwise noted

Symbol	Characteristic	Мах	Units
		*BSR18A	
PD	Total Device Dissipation	350	mW
	Derate above 25°C	2.8	mW/∘C
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient	357	°C/W

*Device mounted on FR-4 PCB 40 mm X 40 mm X 1.5 mm.

PNP General Purpose Amplifier (continued)

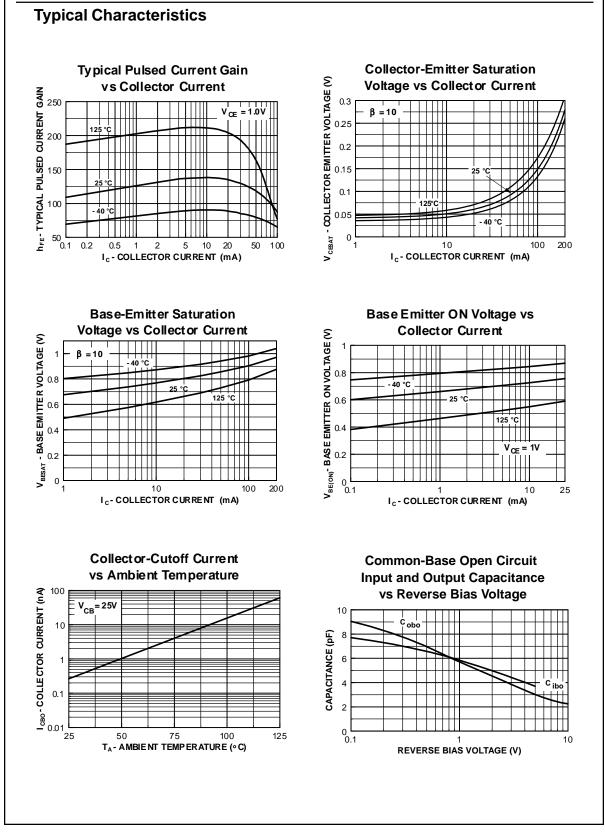
Symbol	Parameter	Test Conditions	Min	Max	Units
OFF CHAI	RACTERISTICS	· · · ·		•	
V _{(BR)CEO}	Collector-Emitter Breakdown Voltage	$I_{C} = 10 \ \mu A, \ I_{B} = 0$	40		V
V _{(BR)CBO}	Collector-Base Breakdown Voltage	$I_{\rm C} = 1.0 \text{ mA}, I_{\rm E} = 0$	40		V
V _{(BR)EBO}	Emitter-Base Breakdown Voltage	$I_{\rm E} = 10 \ \mu A, \ I_{\rm C} = 0$	5.0		V
I _{CBO}	Collector-Cutoff Current	V _{CB} = 30 V		50	nA
I _{EBO}	Emitter-Cutoff Current	$V_{EB} = 3.0 \text{ V}, I_{C} = 0$		50	nA
ON CHAR	ACTERISTICS*				
٦ _{FE}	DC Current Gain	$I_{\rm C} = 0.1 \text{ mA}, V_{\rm CE} = 1.0 \text{ V}$	60		Τ
		$I_{C} = 1.0 \text{ mA}, V_{CE} = 1.0 \text{ V}$	80		
		$I_{C} = 10 \text{ mA}, V_{CE} = 1.0 \text{ V}$ $I_{C} = 50 \text{ mA}, V_{CE} = 1.0 \text{ V}$	100 60	300	
		$I_{C} = 30 \text{ mA}, V_{CE} = 1.0 \text{ V}$ $I_{C} = 100 \text{ mA}, V_{CE} = 1.0 \text{ V}$	30		
V _{CE(sat)}	Collector-Emitter Saturation Voltage	$I_{\rm C} = 10 \text{ mA}, I_{\rm B} = 1.0 \text{ mA}$		0.25	V
		$I_{\rm C} = 50 \text{ mA}, I_{\rm B} = 5.0 \text{ mA}$		0.4	V
V _{BE(sat)}	Base-Emitter Saturation Voltage	$I_{C} = 10 \text{ mA}, I_{B} = 1.0 \text{ mA}$ $I_{C} = 50 \text{ mA}, I_{B} = 5.0 \text{ mA}$	0.65	0.85 0.95	V
SMALL SI	GNAL CHARACTERISTICS Transition Frequency	$I_{c} = 10 \text{ mA}, V_{CE} = 20,$ f = 100 MHz	250		MHz
C _{cb}	Collector-Base Capacitance	$V_{CB} = 5.0 \text{ V}, I_E = 0, f = 100 \text{ kHz}$		4.5	pF
Ceb	Emitter-Base Capacitance	$V_{EB} = 0.5 \text{ V}, I_C = 0, f = 100 \text{ kHz}$		10	pF
h _{ie}	Input Impedance	V _{CE} = 10 V,I _C = 1.0 mA,f=1.0 kHz	2.0	12	kΩ
h _{fe}	Small-Signal Current Gain	V _{CE} = 10 V,I _C = 1.0 mA,f=1.0 kHz	100	400	
h _{oe}	Output Admittance	V _{CE} = 10 V,I _C = 1.0 mA,f=1.0 kHz	3.0	60	μS
SWITCHI	NG CHARACTERISTICS				
t _d	Delay Time	$I_{\rm C} = 10 \text{ mA}, \ I_{\rm B1} = 1.0 \text{ mA},$		35	ns
t _r	Rise Time	V _{EB} = 0.5 V		35	ns
s	Storage Time	$I_{\rm C} = 10 \text{ mA}, I_{\rm Bon} = I_{\rm Boff} = 1.0 \text{ mA}$		275	ns
tr	Fall Time			75	ns
*Pulse Test: P	ulse Width ≤300 μs, Duty Cycle ≤0.01%				
NOTE: All volta	ages (V) and currents (A) are negative polarity for PNP t	ransistors.			

PNP (ls=1.41f Xti=3 Eg=1.11 Vaf=18.7 Bf=180.7 Ne=1.5 Ise=0 lkf=80m Xtb=1.5 Br=4.977 Nc=2 Isc=0 lkr=0 Rc=2.5 Cjc=9.728p Mjc=.5776 Vjc=.75 Fc=.5 Cje=8.063p Mje=.3677 Vje=.75 Tr=33.42n Tf=179.3p ltf=.4 Vtf=4 Xtf=6 Rb=10)

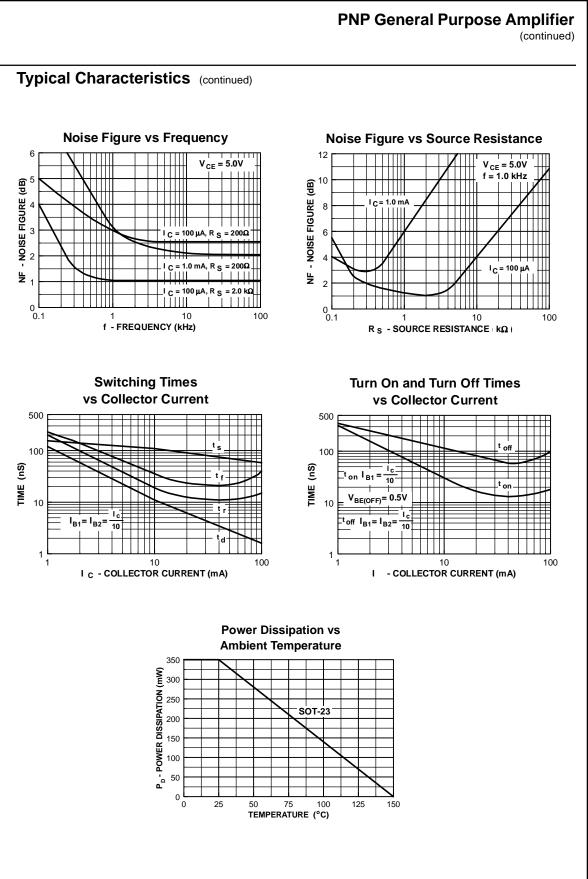
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PNP General Purpose Amplifier (continued)

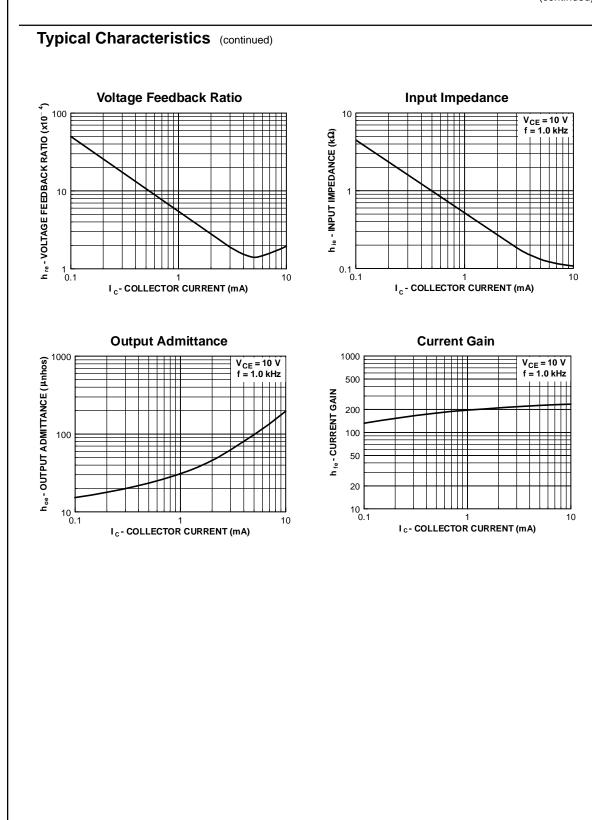


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PNP General Purpose Amplifier (continued)



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PowerTrench[®] QFET™ QS™ QT Optoelectronics[™] Quiet Series[™] SILENT SWITCHER® SMART START™ SuperSOT[™]-3 SuperSOT[™]-6 SuperSOT[™]-8

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PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.
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